

Enhanced transmission of transverse electric waves through subwavelength slits in a thin metallic film

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By coating a cover layer with metallization of cut wire array, the transmission of transverse electric waves (TE; the electric field is parallel to the slits) through subwavelength slits in a thin metallic film is significantly enhanced. An 800-fold enhanced transmission is obtained compared to the case without the cut wires. It is demonstrated that a TE incident wave is highly confined by the cut wires due to the excitation of the electric dipole-like resonance, and then effectively squeezed into and through the subwavelength slits.

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Since the first experimental report of “extraordinary optical transmission” (EOT) through an metallic grating with periodic subwavelength holes [1], there has been considerable interest in the “enhanced” transmission phenomena of subwavelength apertures in metals, such as one-dimensional (1D) periodic arrays of slits [1, 2], two-dimensional (2D) periodic arrays of cylindrical [3, 4] and rectangular (square) holes [5, 6], and a single aperture surrounded by periodic corrugations [7, 8, 9]. It is worth noting that there are two different transmission mechanisms of subwavelength apertures. Since the subwavelength holes do not support the propagating modes, the transmission of incident waves can only rely on the evanescent tunneling process that can be enhanced by either diffraction or surface wave excitation. As to the subwavelength slits, there is always a propagating waveguide mode with no cutoff frequency [10] for transverse magnetic (TM) waves (i.e., the magnetic field parallel to the slits). Utilizing this guided mode can result to strong transmission of TM waves through the slits [11].

Lots of works on the EOT phenomena of subwavelength slits have been reported in microwave and optical frequencies [12, 13, 14]. However, most of them have been focused on TM waves. This paper is dedicated to enhance the transmission of TE waves (i.e., the electric field is parallel to the slits) through subwavelength slits in a thin metallic film. Different from TM waves, the transmission of a TE wave through a subwavelength slit has a cut-off frequency [10], below which no propagating mode exists. By coating a cover layer with a metallization of cut wire array, the transmission of a TE wave through an array of subwavelength slits can be drastically enhanced at a resonant point below the cut-off frequency.

A 1D periodic array of subwavelength slits perforated in an aluminum film is shown in Fig. 1(a). The thickness of the metallic film is $t = 0.5$ mm, the width of the slits is $g = 5.5$ mm, and the period of the slit array is $p = 30$

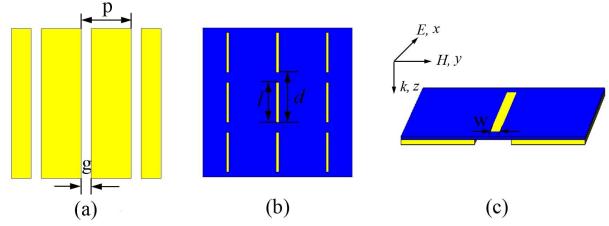


FIG. 1: (a) The top view of 1D periodic slit array perforated in a metallic film. (b) the top view of a cover layer with a metallization of cut wire array. (c) Unit cell for transmission calculation when the cover layer is put perforated film in (a) to enhance the transmission. Axes indicate the propagation direction and polarization of the incident plane wave.

mm (these parameters are chosen to be practical in experiments). By using a Finite-Integration Time Domain algorithm [15], the transmission spectrum of the slit array is calculated and shown by the dashed (red) curve in Fig. 2(a) (where the transmission values are amplified by 50 times to improve the visibility). In calculation, a TE plane wave is normally incident on the structure. Since the considered wavelength ($\lambda > 30$ mm) is much larger than the slit width ($g < \lambda/5$) no propagating mode can be excited by the TE plane wave [10]. So the transmission can only rely on the evanescent tunneling process, and is pretty low (< 0.1%) even for such thin metallic film at microwave frequencies.

To enhance the transmission of the subwavelength slits, a cover layer which is formed of cut wire array metallized on a dielectric substrate is used, as shown in Fig. 1(b). The metallization was in copper with a thickness of 0.02 mm. The cut wires are of length $l = 24$ mm and width $w_1 = 1.6$ mm. The period of the cut-wire array in the x and y directions are $p = 30$ mm and $d = 30$ mm, respectively. The dielectric substrate is of permittivity $\epsilon = 3.0$ and thickness $t_1 = 0.3$ mm. The unit cell of the composite structure for transmission calculation is shown in Fig. 1(c). As the simulation result represents (see the

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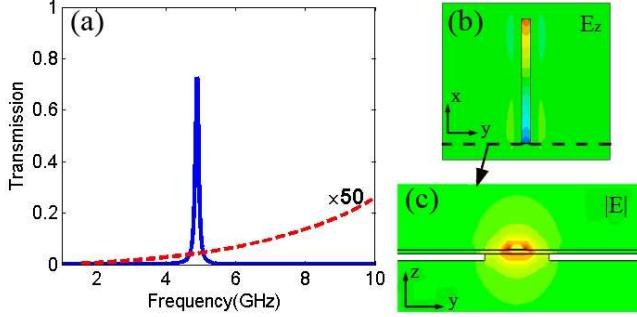


FIG. 2: (color online) (a) Transmission of a slit array with (blue solid curve) and without (red dashed) the cover layer shown in Fig. 1(b). (b) Distribution of the z-component electric field on the cut wire at the resonant frequency. (c) Distribution of the electric field magnitude near the aperture of the slit in the y-z plane at the side edge of the cut wire [see the construction line in Fig. 2(b)].

solid curve in Fig. 2(a)), a resonant transmission peak appears at frequency $\omega = 4.88$ GHz ($\lambda = 61.5$ mm) with transmissivity of up to 72%, which is about 800 times larger than that in the case without the cover layer. At resonance, the distribution of the z-component electric field on the cut wire is shown in Fig. 2(b), which represents that charges of opposite signs accumulate at the two ends of the broken wire, indicating the excitation of a strong electric dipole-like resonance [16] on the cut wire. The distribution of the corresponding electric field magnitude on the y-z plane at the side edge of the cut wire is shown in Fig. 2(c), from which one sees that the resonant electric field is highly localized in a subwavelength range around the cut wire. Based on the strong localized electric field near the input apertures of the slits, the incident wave is effectively coupled into evanescent waves, and then squeezed through the subwavelength slits. Consequently, a striking resonant transmission is obtained. To further demonstrate that the drastic transmission improvement is caused by the electric dipole-like resonance of the cut wires, Fig. 3 shows the transmission for different cut-wire length l , where l varies from 16 mm to 28 mm. The resonant frequency of the transmission peak obviously shifts with l , while the peak amplitude changes little. The corresponding resonant wavelength of the transmission peak is shown by the blue curve in the inset of Fig. 3 as a function of l . For comparison, the resonant wavelength of the fundamental mode (i.e., the electric dipole-like resonant mode) of the cut wires for different l is also shown in the inset of Fig. 3 (red curve). The correlation of the two curves indicates that the resonant transmission frequency is dominantly determined by the resonance of the cut wires. The relatively small frequency difference between the two curves is caused by the interaction of the cut wires with the patterned metallic film.

Next, the influence of the geometric parameters of the

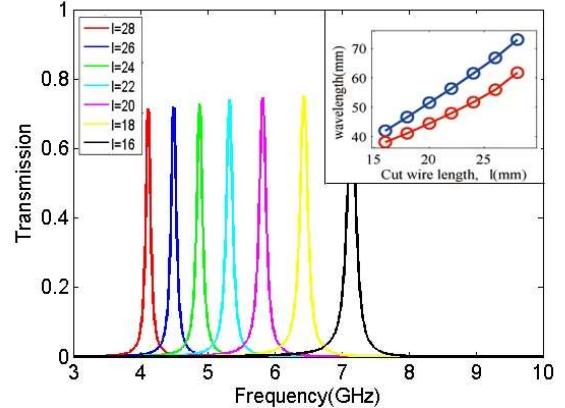


FIG. 3: (color online). Transmission of the composite structure in Fig. 1(c) for different cut-wire length l . The inset shows the resonant wavelength as a function of the cut-wire length l for the composite structure (blue curve) and only the cover layer in Fig. 1(b) (red curve).

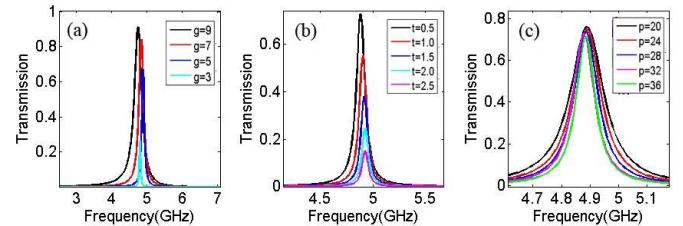


FIG. 4: (Color online). Transmission spectra of the composite structure in Fig. 1(c). The parameters are the same as those in Fig. 2(a), except that (a) g varies from 9 to 3 mm; (b) t varies from 0.5 to 2.5 mm; (c) p varies from 20 to 36 mm.

slit array on the resonant transmission of the composite structure is investigated. Figs. 4(a) and 4(b) show the corresponding transmission when the thickness t of the metallic film and the width g of the slits are changed, respectively. The other parameters are the same as those used in Fig. 2. The amplitude of the resonant transmission peak rapidly drops with the decrease of g and increase of t . It is not unexpected that reducing the size of the apertures and thickening the metallic film will reduce the evanescent wave tunneling and diminish the transmission, like the case of surface plasmon enhanced EOT [19, 20] through the subwavelength hole array. Nevertheless, the current enhanced transmission is not due to surface plasmon, as the incident wave is a TE wave and the structure works at microwave frequencies. In Figs. 4(a) and 4(b), a striking point is that the peak frequency does not obviously shift with the variation of t and g , because the transmission is based on the evanescent tunneling process and the resonant frequency is determined by the cut wires as discussed in the above. Notably, in the previous works on the EOT phenomena of TE waves [17, 18] through the slit which is need to be wide enough to support propagating modes, the frequency of resonant

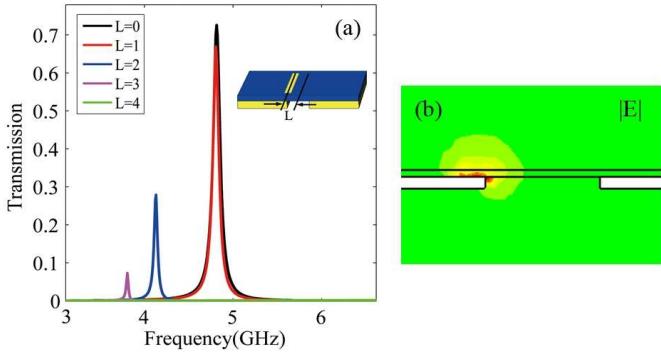


FIG. 5: (color online). (a) Transmission of the structure shown in the inset. The parameters are the same as those used in Fig. 2(a) except L . (b) Distribution of the electric field magnitude in the y-z plane at the side edge of the cut wire for $L = 3$ mm.

transmission is sensitive to the geometric parameters of slits, since the EOT is caused by the excitation of cavity modes in the slits. Fig. 4(c) shows the transmission of the composite structure when the period p is varied. The transmission peak is not perceptibly changed with the variation of p , which indicates that Bloch surface waves [21] are not contributed to the drastically enhanced transmission

It is also interesting to explore the transmission behavior when the cover layer is laterally displaced relative to the patterned metallic film. The lateral shift is denoted by L in the inset of Fig. 5(a). The other parameters are the same as those used in Fig. 2. The transmission for different L is shown in Fig. 5(a). When L is below 1.0 mm, the transmission does not perceptibly change [see the red curve in Fig. 5(a)]. That is to say that the

resonant transmission is quite stable for small lateral displacement which could be easily induced by experimental error. As L is further increased, the amplitude of the resonant transmission peak rapidly drops. When L reaches 4.0 mm, no resonant transmission peak is observed as shown by the green line (overlap with the x-axis) in Fig. 5(a). The distribution of the electric field magnitude in Fig. 5(b) can well explain the above behavior. The electric dipole-like resonance is highly localized around the cut wire. When L is small, the localized resonant field is blocked little by the metallic film, and the transmission is insignificantly influenced. When L becomes large, a part of the localized resonant field is blocked by the metallic film, and the resonant transmission is suppressed since the incident wave can not effectively coupled into the slits. As shown by the above simulation results, this resonant transmission enhancement can be manipulated just by changing the laterally displacement L .

In conclusion, we have numerically demonstrated that at microwave frequencies the transmission of TE waves through subwavelength slits in a thin metallic film can be greatly enhanced by assistant cut wires. The electric dipole-like resonance which makes the incident TE wave tightly confined around the cut wires plays a key role in the enhanced transmission mechanism. Although our numerical calculation were carried out at microwave frequencies, the proposed method of transmission enhancement can be easily extended to terahertz frequencies or optical frequencies due to the simplicity of the present structure.

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